

<b>Notice of References Cited</b>	Application/Control No. 10/775,624		Applicant(s)/Patent Under Reexamination KHAN ET AL.	
	Examiner PHILIP WANG		Art Unit 2191	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,107,578 B1	09-2006	Alpern, David M.	717/124
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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